


Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/082,450	JIAN ZHU ET AL	
	Examiner	Art Unit	
	Habte Mered	2662	

SEARCHED			
Class	Subclass	Date	Examiner
370	386-388	9/23/2006	HM
370	392	9/23/2006	HM
370	299	9/23/2006	HM
370	422	9/23/2006	HM

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Searched EAST DB:USPG-PUB, USPAT, JPO and EPO	9/23/2006	HM
IEEE	9/23/2006	HM
Palm Inventors DB	9/23/2006	HM